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Jackychen Lun (A:

RF EXPOSURE REPORT

Report Reference No..... CTL1606082137-MPE

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Date of issue.....: July 28, 2016

Testing Laboratory Name Shenzhen CTL Testing Technology Co., Ltd.

Floor 1-A, Baisha Technology Park, No. 3011, Shahexi Road, Address

Nanshan, Shenzhen 518055 China.

Techno

Applicant's name..... Highten Electronic Technology Co.,LTD.

Xinmao Building, MingFengRoad, MingZhi Avenue, New LongHua Address:

District, Shenzhen, China

Test specification:

Standard: FCC CFR 47 part1, 1.1307(b), 1.1310

TRF Originator..... Shenzhen CTL Testing Technology Co., Ltd.

Master TRF.....: Dated 2011-01

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Test item description: Wireless Charger

FCC ID...... 2Al92-H20

Trade Mark Blast Motion

Model/Type reference..... H20

Transmit Frequency...... 133KHz

Antenna type Loop antenna

Result Positive

TEST REPORT

Report No.: CTL1606082137-MPE

Test Report No. :	CTL1606082137-MPE	July 28, 2016
	0121000002137-WII C	Date of issue

Equipment under Test : Wireless Charger

Type / Model(s) : H20

Applicant : Highten Electronic Technology Co.,LTD.

Address : Xinmao Building, MingFengRoad, MingZhi Avenue, New LongHua

District, Shenzhen, China

Manufacturer : Highten Electronic Technology Co.,LTD.

Address : Xinmao Building, MingFengRoad, MingZhi Avenue, New LongHua

District, Shenzhen, China

Test Result	AR CTI ARE
rest Result	PASS

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

Contents

SUMMARY	4
EUT configuration	4
TEST ENVIRONMENT	4
Address of the test laboratory Test Facility	4 4
Environmental conditions	4
Statement of the measurement uncertainty	4
METHOD OF MEASUREMENT	<u>5</u>
Applicable Standard	5 5
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TEST RESULT	6
Test Setup	6
Test Equipment Measurement Procedure	6 6
Equipment Approval Considerations	6
E and H field Strength	7
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V1.0 Page 4 of 8 Report No.: CTL1606082137-MPE

1. SUMMARY

1.1. EUT configuration

Kind of Product	Wireless Charger
Model Name	H20
Frequency Range	133KHz
Antenna Type	Inductive loop coil antenna
FCC ID	2Al92-H20

2. TEST ENVIRONMENT

2.1. Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.

Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, China 518055

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.10 (2013) and CISPR Publication 22.

2.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

IC Registration No.: 9618B

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration No.: 9618B on November 13, 2013.

FCC-Registration No.: 970318

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 970318, December 19, 2013.

2.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

 Temperature:
 15-35 ° C

 Humidity:
 30-60 %

Atmospheric pressure: 950-1050mbar

2.4. Statement of the measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

Parameter	Uncertainty
Radio Frequency	±1 x 10 ⁻⁵
total RF power, conducted	±1,5 dB
RF power density, conducted	±3 dB
spurious emissions, conducted	±3 dB
all emissions, radiated	±6 dB
temperature	±1°C
humidity	±5 %
DC and low frequency voltages	±3 %

3. Method of measurement

3.1. Applicable Standard

According to §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to §1.1310 and §2.1091 RF exposure is calculated.

According KDB680106 D01v02: RF Exposure Wireless Charging Apps v02

3.2. Limit

Limits for Maximum Permissible Exposure (MPE)/Controlled Exposure

Frequency	Electric Field	Magnetic Field	Power Density	Averaging Time
Range(MHz)	Strength(V/m)	Strength(A/m)	(mW/cm²)	(minute)
	Limits for Oc	ccupational/Controll	ed Exposure	
0.3 - 3.0	614	1.63	(100) *	6
3.0 - 30	1842/f	4.89/f	(900/f)*	6
30 – 300	61.4	0.163	1.0	6
300 – 1500	1		f/300	6
1500 – 100,000	1	1/	7-5	6

Limits for Maximum Permissible Exposure (MPE)/Uncontrolled Exposure

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Frequency	Electric Field	Magnetic Field	Power Density	Averaging Time			
Range(MHz)	Strength(V/m)	Strength(A/m)	(mW/cm²)	(minute)			
Limits for Occupational/Controlled Exposure							
0.3 - 3.0	614	1.63	(100) *	30			
3.0 - 30	824/f	2.19/f	(180/f)*	30			
30 – 300	27.5	0.073	0.2	30			
300 – 1500	THE RESERVE TO SERVE	17/14	f/1500	30			
1500 – 100,000	9		1.0	30			

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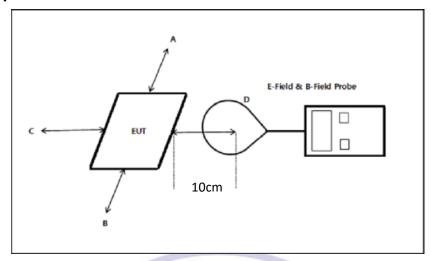
F=frequency in MHz

^{*=}Plane-wave equivalent power density

V1.0 Page 6 of 8 Report No.: CTL1606082137-MPE

4. Test Result

4.1. Test Setup



Note: A, B, C, D, E, F for six surfaces of the product.

4.2. Test Equipment

Equipment	Manufacturer	Model	Serial no.	Calibrated date	Calibrated until
E-Field Probe	CHROMA	MFM 2000	CR18G46Y	2016.6.1	2017.5.31
H-Field Probe	CHROMA	MFM 2000	CR18G46Y	2016.6.1	2017.5.31

4.3. Measurement Procedure

- a) The RF exposure test was performed on 360 degree turn table in anechoic chamber.
- b) The measurement probe was placed at test distance (10cm) which is between the edge of the charger and the geometric centre of probe.
- c) The turn table was rotated 360d degree to search of highest strength.
- d) The highest emission level was recorded and compared with limit as soon as measurement of each points (A, B, C, D, E) were completed.
- e) The EUT were measured according to the dictates of KDB 680106D01v02.

4.4. Equipment Approval Considerations

The EUT does comply with item 5.2 of KDB 680106 D01v02

- a) Power transfer frequency is less than 1MHz.
 - Yes; the device operate in the frequency range from 133 KHz
- b) Output power from each primary coil is less than 5 watts

Yes; the maximum field strength of fundamental: 72.58 dBuV/m at 3 meter. The EIRP calculation is reference to KDB789033.

EIRP [dBm] =E [dBuV/m] +20log (d [metres])-104.77[dB], d=3m

72.58 dBuV/m -95.2-4.8=-27.42dBm EIRP

The output power from primary coil is 0.0018mW

- c) The transfer system includes only single primary and secondary coils. This includes charging systems that may have multiple primary coils and clients that able to detect and allow coupling only between individual pair of coils.
 - Yes; the transfer system includes only single primary and secondary coils.
- d) Client device is inserted in or placed directly in contact with the transmitter.
 - Yes; Client device is placed directly in contact with the transmitter.
- e) The maximum coupling surface area of the transmit (charging) device:
 - Yes; The EUT coupling surface area was 36.31 cm²<60cm²
- f) Aggregate leakage fields at 10cm surrounding the device from all simultaneous transmitting coils are demonstrated to be less than 30% of the MPE limit.
 - The EUT E and H field strength levels << 30% X MPE limit. Please refer to below E and H field Strength test results.

4.5. E and H field Strength

Test mode for wireless charger: Normal Operation (Charging mode)

E-Filed Strength at 10 cm from the edges surrounding the EUT

	Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Test Position F	Limits (V/m)
I	0.133	1.29	1.13	1.02	0.99	1.17	0.96	614.0

H-Filed Strength at 10 cm from the edges surrounding the EUT

Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Test Position F	Limits (A/m)
0.133	0.147	0.141	0.149	0.141	0.148	0.140	1.63

Test mode for wireless charger: Normal Operation (No load mode)

E-Filed Strength at 10 cm from the edges surrounding the EUT

Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Test Position F	Limits (V/m)
0.133	1.02	0.94	0.88	0.72	0.82	0.59	614.0

H-Filed Strength at 10 cm from the edges surrounding the EUT

Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Test Position F	Limits (A/m)
0.133	0.098	0.101	0.074	0.080	0.071	0.085	1.63

Test Setup Photo





